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Radiation-induced structural changes in chalcogenide glasses as revealed from Raman spectroscopy measurements

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Abstract. Radiation-induced structural changes in the chalcogenide glasses of $(As_2S_3)_x(GeS_2)_{1-x}$ system with x = 0.1, 0.2, 0.4, and 0.6 corresponding to the chemical compositions $Ge_{28.125}As_{6.25}S_{65.625}$, $Ge_{23.5}As_{11.8}S_{64.7}$, $Ge_{15.8}As_{21}S_{63.2}$, and $Ge_{9.5}As_{28.6}S_{61.9}$, respectively, were studied using the Raman spectroscopy technique in detail. The polarized (VV) and depolarized (VH) Raman spectra were recorded separately for two identical samples in the unirradiated and γ -irradiated states which allowed performing all measurements under the same experimental conditions. The Raman spectra were considered in the regions of high-frequency excitations related with the molecular peak, and low-frequency excitations related with the boson peak. The depolarization ratio spectra for the unirradiated and γ -irradiated samples were examined, too. The differential Raman spectra in the high-frequency region between unirradiated and γ-irradiated samples were obtained only in the VH configuration, since no spectral variations in the VV configuration were detected for all the compositions studied. Employing the differential representation ($I_{\rm irrad.}^{\rm R} - I_{\rm unirrad.}^{\rm R}$) of the VH Raman spectra measured for the γ irradiated ($I_{\text{irrad.}}^{\text{R}}$) and unirradiated ($I_{\text{unirrad.}}^{\text{R}}$) samples, it has been found out that the radiation-induced structural changes are significant only for the glass composition with x = 0.4, while these changes are practically absent in the case of the glass compositions with x = 0.1, 0.2, and 0.6. The applied differential procedure allows also to detect the radiation-induced effects in clusters of corner-shared and edge-shared tetrahedral, which was not possible with IR Fast Fourier Transform spectroscopy due to different activity of IR and Raman bands. In addition, it was shown that the controversial companion A_1^c mode at 370 cm^{-1} to the main 340 cm^{-1} A_1 symmetric mode of vibrations in cornershared tetrahedra seems to be related mainly to the vibrations of edge-shared tetrahedra. The possible nanoscale structural mechanism to account for these spectral changes has been discussed.

Keywords: Raman spectroscopy, chalcogenide glasses, radiation modification.

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1. Introduction

Chalcogenide glasses are known to be sensitive to external influences such as photoexposure [1-5] and high-energy ionizing irradiation (γ -quanta [6-10], accelerated electrons [10-13], protons [14]). A great number of results testify in favour of a phenomenological similarity between photo- and

radiation-induced effects in these glasses despite the role of chemical composition, preparation method and thermal pre-history of samples.

The Raman scattering technique is a powerful experimental tool for investigation of vibrational properties and structure of materials, and, in particular, chalcogenide glasses. In the early 80-s, this method was successfully applied to study reversible photostructural

transformations in amorphous As₂S₃ [1, 2, 15-17]. It was shown with account of the obtained Raman spectra that this effect is accompanied by switching of heteropolar heteronuclear) bonds into homopolar homonuclear) ones [15, 16]. This method also allowed explaining the optically induced crystal-to-amorphousstate transition in As₂S₃ as non-thermal effect probably promoted by a high density of induced defects [17]. Besides, Raman scattering measurements along with EXAFS data clearly indicated a reversible increase in the coordination number of Se in the photoexcited state due to additional dynamic bonds between pairs of over-Application of Raman coordinated sites [18]. spectroscopy is also reasonable for better understanding the photostructural changes in ternary chalcogenide glassy systems [3-5, 19, 20]. New evidence of light-induced structural changes in As-S glasses was obtained by photon energy dependent Raman spectroscopy [21].

In this work, Raman spectroscopy is used to study high-energy γ-irradiation-induced structural changes in chalcogenide glasses. The earlier obtained Raman results for the selected chalcogenide glass of $(As_2S_3)_x(GeS_2)_{1-x}$ system with x = 0.4 and chemical composition Ge_{15.8}As₂₁S_{63.2} [22] showed that the radiation-induced shift of the main molecular band from 340 to 335 cm⁻¹ takes place in the depolarized (VH) configuration. This shift was assigned due to structural transformations in the glass network under radiation. The aim of this work is to analyze deeper the radiation-induced structural changes in the Ge_{15.8}As₂₁S_{63.2} glass and as compared to other alloys of the $(As_2S_3)_x(GeS_2)_{1-x}$ system with x = 0.1, 0.2, and 0.6 and corresponding chemical compositions $Ge_{28.125}As_{6.25}S_{65.625}$, $Ge_{23.5}As_{11.8}S_{64.7}$, and $Ge_{9.5}As_{28.6}S_{61.9}$, respectively. The Raman spectra will be considered in the regions of high-frequency excitations related with the molecular peak, and low-frequency excitations related with the boson peak. The depolarization ratio for the unirradiated and y-irradiated samples will be examined, too. The radiation-induced structural changes will be detected in the differential representation $(I_{irrad.}^{R} - I_{unirrad.}^{R})$ of the VH Raman spectra measured for the γ -irradiated ($I_{\text{irrad.}}^{\text{R}}$) and unirradiated ($I_{\text{unirrad.}}^{\text{R}}$) samples.

2. Experimental

The investigated bulk glasses were prepared using the standard melt-quenching procedure with cooling in water as was described in detail elsewhere [23]. After synthesis the ingots were cut to the parallel disks (\sim 1 mm in thickness), which then were polished to high optical quality. The disk glassy samples were tested separately in two structural configurations such as unirradiated (or reference) and γ -irradiated ones. Before experimental measurements the samples were annealed at 20-30 K below the glass transition temperature T_g during 1 hour [24].

The radiation treatment of the samples was performed by γ -quanta with the absorbed dose Φ = 2.41 MGy and the average energy E = 1.25 MeV under the normal conditions of stationary radiation field created in the closed cylindrical cavity owing to concentrically maintained 60 Co sources. No special measurements were done to prevent the uncontrolled thermal annealing of the sample, but the maximum temperature in irradiating camera did not exceed 330 K during the whole period of γ -treatment (about 2 to 3 months).

The Raman spectra were excited using 647.1 nm $\rm Kr^+$ laser line at a power density of 40 mW in a pseudo-backscattering geometry. Collected scattered light was analyzed by SPEX 1403 double monochromator operated at a spectral bandpass of 1.5 cm⁻¹ and detected by a cooled photomultiplier. The Raman spectra were recorded separately in both VV and VH configurations corresponding to parallel (VV "vertical-vertical") and crossed (VH "vertical-horizontal") polarizations between incident and scattered light. In order to make the comparative analysis of the data obtained for the unirradiated and γ -irradiated samples, the measured Raman spectra were normalized to the intensity of the main molecular band at 340 cm⁻¹. All the measurements were made at room temperature.

3. Results

The normalized Raman spectra of unirradiated and γ -irradiated samples with x=0.4 (chemical composition $Ge_{15.8}As_{21}S_{63.2}$) in the VV and VH configurations are shown in Fig. 1 [22, 25]. One can see that no change in the Raman spectra for the VV configuration is observed, while the spectrum for the VH configuration is sufficiently modified in the γ -irradiated state. As a result of radiation-induced effect on the glass structure, the shift of the main molecular band at 342 cm⁻¹ to the new position at 335 cm⁻¹ is detected. Besides, the radiation-induced changes in the intensity of the bands at 490, 430, 370, 237, and 205 cm⁻¹ are also identified.

The depolarization ratio spectra ($\rho(\omega) = I_{VH}/I_{VV}$), the ratio of the scattering intensity in two configurations (VH/VV) within the whole spectral range for the unirradiated and y-irradiated samples with x = 0.4 are presented in Fig. 2. The observed two local minima in the range $200-250 \text{ cm}^{-1}$ and one local minimum in the range $300-400 \text{ cm}^{-1}$ and at 430 cm^{-1} for the unirradiated sample could be influenced by the depolarization ratio of the optical TO-type phonon vibrational bands. In the case of γ-irradiated sample, the sharper drop in the depolarization ratio at 200 – 250 cm⁻¹, $300 - 400 \text{ cm}^{-1}$ and 430 cm^{-1} is detected with twining (two local minima) within the range of 300 to 400 cm⁻¹. The plateau between 100 and 200 cm⁻¹ as well as rise to higher values ($\rho(\omega)$ ~0.6) along with Raman frequency shift decreasing below 100 cm⁻¹ (the low-frequency Raman spectra region or region of the so-called "boson

peak") is also observed as more clearly pronounced in the γ -irradiated state (see insert in Fig. 2).

Fig. 3 illustrates the differential normalized VH Raman spectrum ($I_{irrad.}^R - I_{unirrad.}^R$) between γ -irradiated ($I_{irrad.}^R$) and unirradiated ($I_{unirrad.}^R$) samples with x = 0.4 (Ge_{15.8}As₂₁S_{63.2}) as compared to the differential spectra of other alloys in the (As₂S₃)_x(GeS₂)_{1-x} system with x = 0.1 (Ge_{28.125}As_{6.25}S_{65.625}), x = 0.2 (Ge_{23.5}As_{11.8}S_{64.7}), and x = 0.6 (Ge_{9.5}As_{28.6}S_{61.9}) [26]. One can see appearance of positive and negative intensity peaks only for the glass composition with x = 0.4, corresponding to the created and destructed covalent bonds, respectively, like to conventional IR FFT spectrum of additional γ -induced reflectivity [27], while the spectral changes are practically absent in the case of the glass compositions with x = 0.1, 0.2, and 0.6.

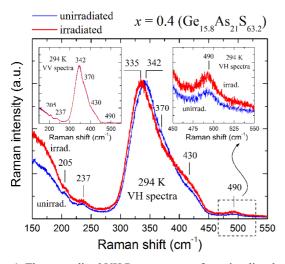


Fig. 1. The normalized VH Raman spectra for unirradiated and γ-irradiated glasses of the $(As_2S_3)_x(GeS_2)_{1-x}$ system with x = 0.4 ($Ge_{15.8}As_{21}S_{63.2}$). Inserts show corresponding Raman spectra in VV polarization (left) and VH polarization in the vicinity of 490 cm⁻¹ band (right).

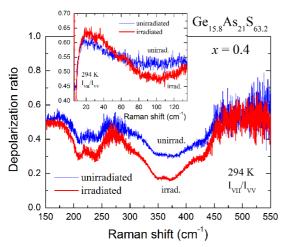


Fig. 2. The high-frequency depolarization ratio spectra $(\rho(\omega) = I_{VH}/I_{VV})$ for unirradiated and γ-irradiated glasses of the $(As_2S_3)_x(GeS_2)_{1-x}$ system with x = 0.4 $(Ge_{15.8}As_{21}S_{63.2})$. Insert shows respective low-frequency depolarization ratio spectra.

It must be noted that the radiation-induced changes in the VV and VH Raman spectra obtained are similar to the light-induced ones examined by Kolobov *et al.* [18] for amorphous a-Se film. As well as in the case of γ-irradiated and unirradiated Ge_{15.8}As₂₁S_{63.2} glasses (Fig. 1), no significant changes in the Raman spectra between unilluminated and illuminated a-Se for the VV configuration and in the strongly modified Raman spectrum for the VH configuration with appearance of new bands in the photoexcited state of a-Se have been detected [18].

Fig. 4 shows the polarized-VV and depolarized-VH Raman spectra of $(As_2S_3)_{0.2}(GeS_2)_{0.8}$ glass taken as an example. The low-frequency vibrational region of the Raman spectrum in both VV and VH configurations is characterized by the presence of the excess quasi-elastic light scattering well fitted using the Theodorakopoulos-Jäckle model [28] as shown schematically by lines with arrows in insert of Fig. 4. The larger excess quasi-elastic light scattering is found for the VV configuration than for the VH one, and, thus, the low-frequency vibrational excitations called 'boson peaks' (BP) are analyzed using the Raman spectra recorded in the VH configuration.

Fig. 5 demonstrates the ratio of the BP intensity to that of the main molecular peak at 340 cm⁻¹, I_{bos}/I_{mol} , often attributed to the degree of disorder in amorphous solids on the medium-range order (MRO) scale [29-31] for the unirradiated and γ -irradiated $(As_2S_3)_x(GeS_2)_{1-x}$ glasses as a function of composition x. Insert of Fig. 5 displays the difference in the $I_{\rm bos}/I_{\rm mol}$ values between γ irradiated and unirradiated samples. The largest radiation-induced changes of the disorder degree are observed for the alloy with x = 0.4 (Ge_{15.8}As₂₁S_{63.2}), which agrees well with the detected radiation-induced shift of the main molecular band at 342 cm⁻¹ to the new position at 335 cm⁻¹ only for this compound (Fig. 1). In contrast to the BP intenisty, the BP position does not show changes under radiation, within experimental errors.

4. Discussion

Taking into account the VV and VH Raman spectra measured for the investigated sample with x = 0.4 in the unirradiated state, one can see the series of Raman bands at 490, 430, 370, 342, 237 and 205 cm⁻¹ (Fig. 1). The same Raman bands are also observed for the unirradiated samples with x = 0.1, 0.2, and 0.6 (exception is the band at 370 cm⁻¹, which is not detected for the alloy with x = 0.6). The main band at 342 cm⁻¹ is related to symmetric A₁-type bond stretching mode of GeS₄ tetrahedra and AsS₃ pyramids [30-34] with the former units being more likely as a glass and corresponds to the $(As_2S_3)_{0.4}(GeS_2)_{0.6}$ formula. The band at 370 cm⁻¹ is attributed to the so-called A_1^c companion mode [34]. The band at 430 cm⁻¹ is assigned to edge-shared tetrahedra [34, 35] or S-S dimers [34, 36] at the edge of the so-called "outrigger raft" clusters proposed for

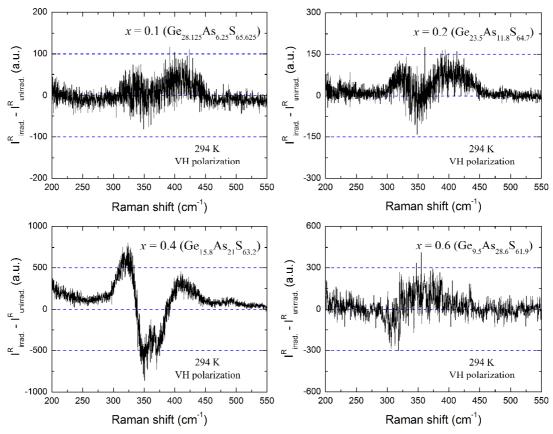


Fig. 3. The differential depolarized Raman spectra between γ -irradiated ($I_{\text{irrad.}}^{\text{R}}$) and unirradiated ($I_{\text{unirrad.}}^{\text{R}}$) glasses of $(\text{As}_2\text{S}_3)_x(\text{GeS}_2)_{1-x}$ (x=0.1, 0.2, 0.4, 0.6) system. All the spectra were normalized to the intensity of the main Raman band at 340 cm^{-1} before substraction.

glassy g-GeSe(S)₂ [37]. The mode at 490 cm^{-1} corresponds to S-S vibrations possibly in S₈ rings [38-42] or rather in covalent S₂ groups (S-S disulfide bonds) [34, 43]. The very weak mode at 205 cm⁻¹ is in accordance with the ab-initio calculated Raman peak at 211 and 212 cm⁻¹ for $SGe_3 - S_{6/3}$ cluster in g-GeS₂ [44]. The mode at 237 cm⁻¹ can be attributed to the structural units all having tri-coordinated S or Ge (SGe_{3/3}, SGe₃ - $S_{6/3}$, and $GeS_{3/3}$), as no other clusters have any peaks below 250 cm⁻¹ in g-GeS₂ [44] as well as to vibrations of As - As bonds in molecular fragments of As₄S₄ [41, 42]. Besides these Raman bands identified, appearance of the new band at 335 cm⁻¹ instead of 342 cm^{-1} mode in the γ -irradiated state only for the sample with x = 0.4 testifies in favour of specific radiation-induced structural transformations in the glass matrix. This new band is detected in the VH configuration, and it should be attributed to the symmetric bond stretching mode of AsS₃ pyramids, which was previously observed in amorphous a-As_xS_{1-x} system with a low As concentration [33, 45] and in g- $Ge_x As_{10} S_{90-x}$ with a low Ge content [46]. In addition, the band at 335 cm⁻¹ is related to the symmetric stretching As – S mode with the four-fold coordinated As atom in

the local quasi-tetrahedral structure of binary As_xS_{1-x} glasses for $0.08 \le x \le 0.37$, as revealed from Raman scattering and supported by the first-principles cluster calculations [47]. Recently, Chrissanthopoulos et al. [48], using the first-principles cluster calculations or density functional theoretical (DFT) calculations performed for the GeS2-In2S3-AgI glasses, have shown that the band at 335 cm⁻¹ is also attributed to the symmetric stretching Ge - S mode in the GeS₄ tetrahedra. In other words, due to similar electronic structure for As and Ge atoms, both the symmetric stretching As – S mode in the quasi-tetrahedral units and the symmetric stretching Ge-S mode in the tetrahedral units are nearly degenerate at 335 cm⁻¹ from DFT calculations. However, since the symmetric stretching As – S mode with the four-fold coordinated As atom was also observed experimentally by Raman measurements of the S-rich glasses of As_xS_{1-x} system [47], we believe that the detected new band at 335 cm⁻¹ instead of 342 cm⁻¹ under radiation is correctly attributed to the symmetric stretch vibrations of As – S bonds.

Why spectral changes are detected only in the VH configuration under radiation? To answer, we assume that the suggestion made for a-Se [18], explaining photo-

induced peaks in the VH configuration of Raman spectra, should be applied in our case accepting a similarity between light- and γ -induced effects in chalcogenide glasses [49, 50]. Thus, for instance, one of the reasons is that the radiation-induced peaks may be more clearly pronounced in the VH configuration, since the signal in the depolarized configuration is smaller than that in the polarized one.

Large depolarization ratios (Fig. 2) are associated with intrinsic anisotropy of the glasses, and the increase in depolarization ratio can be accompanied by the increase in the inelastic Raman scattering cross section [51]. The largest depolarization ratio is detected in the BP range, $\rho(\omega) \sim 0.6$, and consequently the intrinsic anisotropy of the glass can be explained by MRO features tightly related with the BP parameters. The small effect observed at the increase of the depolarization ratio in the BP range in the γ -irradiated state (insert, Fig. 2) testifies existence of possible radiation-induced additional intrinsic anisotropy in the glass studied on the MRO scale. The observed effect correlates with known photo-induced anisotropy in chalcogenide glasses [52]. Sharper drop in the depolarization ratio of the y-irradiated sample as compared to unirradiated one in the high-frequency region of the depolarization ratio spectra can be caused by decreasing the inelastic Raman scattering cross probably, due to radiation-structural transformations. Appearance of a new local minimum within the range 300 to 400 cm⁻¹ under radiation confirms atomic rearrangement in the glass backbone resulting in formation of radiation-induced defects.

The differential VH Raman spectra $(I_{irrad.}^{R} I_{\text{unirrad.}}^{\text{R}}$ (Fig. 3) seem to be important similarly to conventional IR FFT spectra of additional γ-induced reflectivity [27]. Namely, the differential procedure allows to separate the chemical bonds formed within radiation-induced structural transformations (upper zero) with that preferred in the unirradiated state (under zero). The observed appearance of positive and negative intensity peaks only for the glass composition with x = 0.4, while the spectral changes are practically absent in the case of the glass compositions with x = 0.1, 0.2and 0.6, shows clearly that the specific radiation-induced structural transformations occur exclusively for the alloy with x = 0.4. According to the XRD and EXAFS study of the stoichiometric arsenic-germanium sulfide glasses of $(As_2S_3)_x(GeS_2)_{1-x}$ system $(0.0 \le x \le 1.0)$ [53] in combination with the reverse Monte-Carlo simulation [54], the structural order of As-rich (x > 0.4) and Ge-rich (x < 0.4) glasses is organized by the main As – S and Ge-S structural motifs based on pyramidal AsS₃ and tetrahedral GeS_4 units linked by =As-S-As= and \equiv Ge-S-Ge \equiv structural configurations, respectively, whereas for the intermediate compound with x = 0.4, the structural network is better homogeneous on the nanoscale due to appearance of $\equiv Ge - S - As = mixed$ structural configurations, and the structure of this alloy

is similar to the structure of the stoichiometric glass $Ge_{18.2}As_{18.2}S_{63.6}$ (i.e., x = 0.455) consisting of a cornershared network of homogeneously mixed GeS₄ tetrahedra and AsS3 pyramids reported by Soyer-Uzun et al. [55]. The existence of $\equiv Ge - S - As = mixed$ structural configurations supports the γ-induced covalent bond switching heteropolar or heteronuclear Ge-S bonds into heteropolar or heteronuclear As – S ones [the reaction (1) with the $\equiv Ge - S - As = configuration$: $(Ge - S) \rightarrow (As - S)$] accompanied by formation of atomic pairs of positively charged over-coordinated arsenic and negatively charged under-coordinated germanium $(As_4^+ + Ge_3^-)$, the so-called coordination defects or valence alternation pairs (VAPs) [56], as shown schematically in Fig. 6 (the plus (+) sign indicates that there is no chemical bond between the charged centers [57]). This reaction (1) agrees well with appearance of the positive intensity peak in the vicinity of $325 - 335 \text{ cm}^{-1}$ (Fig. 3), corresponding to the vibrations of As-S bonds, created under radiation, in the local structural configuraions with the four-fold coordinated As atom (i.e., As₄⁺ defects).

Other two positive intensity peaks are observed in the vicinity of $420-430 \,\mathrm{cm^{-1}}$ and $490 \,\mathrm{cm^{-1}}$ for the alloy with x=0.4, while the splitting of the negative intensity band with the clear two peaks at 340-350 and $370-375 \,\mathrm{cm^{-1}}$ takes place (Fig. 3). As mentioned above, the positive intensity peaks at $430 \,\mathrm{and} \,490 \,\mathrm{cm^{-1}}$ are related to the edge-sharing tetrahedra or S-S dimers at the edge of "outrigger raft" clusters and covalent S-S bonds, respectively. The negative two peaks at $340 \,\mathrm{and} \,370 \,\mathrm{cm^{-1}}$ correspond to A_1 symmetric mode of Ge-S bond vibrations in the corner-shared GeS_4 tetrahedra and A_1^c companion mode of Ge-S bond vibrations in the edge-shared GeS_4 tetrahedra, respectively, although the structural origin of the companion mode remains a subject of considerable controversy [36, 58].

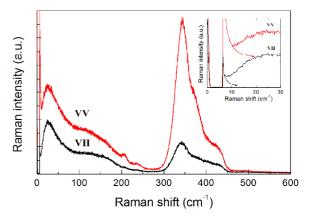


Fig. 4. The polarized-VV and depolarized-VH Raman spectra of $(As_2S_3)_{0.2}(GeS_2)_{0.8}$ glass, taken as an example, with the excess quasi-elastic light scattering in the low-frequency vibrational region well fitted using the Theodorakopoulos-Jäckle model [28] as shown schematically by lines with arrows in insert (see the text for details).

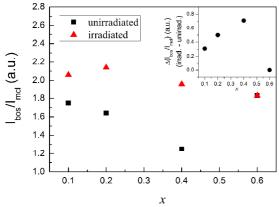


Fig. 5. The ratio of the intensity of the boson peak to the intensity of the main molecular peak at $340~\rm cm^{-1}$, $I_{\rm bos}/I_{\rm mol}$, for unirradiated and γ -irradiated glasses of the $({\rm As_2S_3})_x({\rm GeS_2})_{1-x}$ system as a function of composition x. Insert shows the difference, $\Delta(I_{\rm bos}/I_{\rm mol})$, between values of $I_{\rm bos}/I_{\rm mol}$ for γ -irradiated (irrad.) and unirradiated (unirrad.) samples.

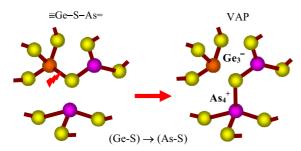


Fig. 6. The schematical illustration of γ -induced covalent bond switching heteropolar or heteronuclear Ge – S bonds into heteropolar or heteronuclear As – S bonds [the reaction (1) with the \equiv Ge – S – As = configuration: (Ge – S) \rightarrow (As – S)] accompanied by formation of atomic pairs of positively charged over-coordinated arsenic and negatively charged under-coordinated germanium As $_4^+$ + Ge $_3^-$, VAP defects (see the text for details).

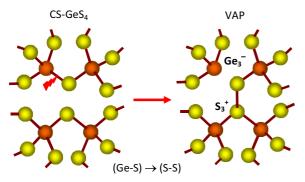


Fig. 7. The schematical illustration of γ -induced covalent bond switching heteropolar or heteronuclear Ge-S bonds in the corner-shared (CS) tetrahedral configuration into homopolar or homonuclear S-S bonds [the reaction (2) with the CS-GeS₄ configuration: $(Ge-S) \rightarrow (S-S)$] accompanied by formation of atomic pairs of positively charged over-coordinated sulfur and negatively charged under-coordinated germanium $(S_3^+ + Ge_3^-)$, VAP defects (see the text for details).

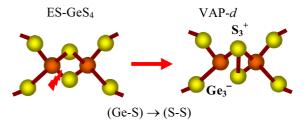


Fig. 8. The schematical illustration of γ -induced covalent bond switching heteropolar or heteronuclear Ge-S bonds in the edge-shared (ES) tetrahedral configuration into homopolar or homonuclear S-S bonds [the reaction (3) with the ES-GeS₄ configuration: $(Ge-S) \rightarrow (S-S)$] accompanied by formation of bound atomic pairs of positively charged over-coordinated sulfur and negatively charged under-coordinated germanium defects ($S_3^+ \cdot Ge_3^-$), VAP-d defects (see the text for details).

Appearance of the positive intensity peak at 490 cm⁻¹ (covalent S-S bonds) under radiation can be explained by the y-induced covalent bond switching heteropolar or heteronuclear Ge-S bonds in the cornershared (CS) tetrahedral configuration into homopolar or homonuclear S-S bonds [the reaction (2) with the CS-GeS₄ configuration: $(Ge - S) \rightarrow (S - S)$] accompanied by formation of atomic pairs of positively charged overcoordinated sulfur and negatively charged undercoordinated germanium $(S_3^+ + Ge_3^-)$, VAP defects (Fig. 7). These radiation-induced transformations (i.e., the reaction (2)) are suggested to be dominant in the case of Ge-Sb-S glasses of stoichiometric Sb₂S₃-GeS₂ system (examplified by Ge_{23.5}Sb_{11.8}S_{64.7} glass) studied using high-resolution Xray photoelectron spectroscopy (XPS) [59] as well as non-stoichiometric Sb₂S₃-Ge₂S₃ or Ge_xSb_{40-x}S₆₀ system (examplified by $Ge_{25}Sb_{15}S_{60}$, $Ge_{27}Sb_{13}S_{60}$, and glasses) studied using high-energy $Ge_{35}Sb_5S_{60}$ synchrotron X-ray diffraction (XRD), extended X-ray absorption fine structure (EXAFS) spectroscopy and infrared spectroscopy [60-62].

Analyzing spectral changes in the vicinity of 430 cm⁻¹, special attention should be paid to understand better the origin of this mode with account of some experimental observations. Namely, the increase of the 430 cm⁻¹ mode with increasing the incident light energy found in g-GeS2 indicates the existence of electronic states near the band edges leading to the reduction of Sbased lone-pair (lp) states [58]. In interpretation of the 430 cm⁻¹ band assigned to the S – S dimers and/or edgeshared tetrahedra, both these units can be expected to contribute to formation of localized, band-tail states that, according to Yamaguchi et al. [58], are responsible for the resonance features of this mode in g-GeS2. Comparatively, the relative intensities of the 430 and 490 cm⁻¹ S-related modes increase with growth in the incident light energy [58].

The similar interpretation is possible in the case of γ-irradiation-induced effect studied. The observed increase in the intensity of 490 cm⁻¹ S-related mode (covalent S-S bonds) under radiation according to the reaction (2), resulting in formation of the $(S_3^+ + Ge_3^-)$ VAPs, agrees well with reduction of S-based lp states due to S_3^+ defects. It should be noted here that the reduction of S-based lp states caused by appearance of over-coordinated S atoms within the $(S_3^+ + Ge_3^-)$ VAPs has also been supported by high-resolution XPS study of reversible y-induced structural transformations in vitreous Ge_{23.5}Sb_{11.8}S_{64.7} [59]. Alternatively, the observed increase in the intensity of 430 cm⁻¹ S-related mode (S-S dimers and/or edge-shared tetrahedra) under radiation seems to be related with reduction of Sbased lp states owing to the y-induced covalent bond switching heteropolar or heteronuclear Ge-S bonds in the edge-shared (ES) tetrahedral configuration into homopolar or homonuclear S-S bonds [the reaction (3) with the ES-GeS₄ configuration: $(Ge - S) \rightarrow (S - S)$ accompanied by formation of bound atomic pairs of positively charged over-coordinated sulfur and negatively charged under-coordinated germanium defects $(S_3^+ \cdot Ge_3^-)$, known as valence alternation pairs dipole (VAP-d), as shown in Fig. 8 (the point (·) sign indicates that there is a chemical bond between the charged centers [57]). Using the quantum-chemical modeling approach Dembovskii et al. [57] showed that the VAP-d defects are even more energetically favored than conventional VAP ones, but the VAP-d defects are more stable when the rigid environment around the defects does exists. Obviously, in the case of the reaction (3), this rigid environment around VAP-d ($S_3^+ \cdot Ge_3^-$) defects should be attained due to "outrigger raft" clusters in the ES-GeS₄ configuration [37]. The radiationinduced VAP-d ($S_3^+ \cdot Ge_3^-$) defects, schematically presented by the atomic-size model in Fig. 8, are also reported for the radiation-modified Ge₃₅Sb₅S₆₀ glass, as revealed from high-energy XRD measurements [60].

Boolchand et al. [36] noted that the density of vibrational states (DOVS) calculations in specific molecular clusters allows to interpret the companion A_1^c mode at 370 cm⁻¹ as a cluster edge mode as well as the 430 cm⁻¹ mode is also typical to the S-S stretch coming from cluster edge dimers. So, on the one hand, the DOVS calculations indicate the 370 and 430 cm⁻¹ modes seem to be interrelated. On the other hand, recent abinitio or DFT calculations of Raman spectra in GeS2 glass [63] showed the 370 cm⁻¹ feature can be attributed to the companion A_1^c mode of vibrations in edge-shared tetrahedra. It means from the theoretical viewpoint that changes in the vibrational properties in the ES-GeS₄ (370 cm⁻¹) and S-S cluster edge dimers (430 cm⁻¹) are supposed to be correlated. The obtained results agree well with the above mentioned theoretical calculations,

giving therefore the first experimental evidence of correlation between the 370 and 430 cm⁻¹ modes as far as we know.

The composition dependence of the disorder degree examplified by the ratio of I_{bos}/I_{mol} (Fig. 5) supports the specific radiation-induced structural changes observed for the alloy with x = 0.4. Namely, in the unirradiated state, the minimum value of $I_{\text{bos}}/I_{\text{mol}}$ attained at x = 0.4 $(Ge_{15.8}As_{21}S_{63.2})$ testifies the smallest degree of disorder for this compound, most probably, due to the existence of $\equiv Ge - S - As = mixed$ structural configurations resulting in the best homogeneous structure similarly to the structure of the stoichiometric glass x = 0.455 $(Ge_{18.2}As_{18.2}S_{63.6})$ consisting of a corner-shared network of homogeneously mixed GeS4 tetrahedra and AsS3 pyramids [55]. At the same time, the radiation-induced change in the $I_{\text{bos}}/I_{\text{mol}}$ magnitude $\Delta(I_{\text{bos}}/I_{\text{mol}}) =$ $([I_{bos}/I_{mol}]_{irrad.} - [I_{bos}/I_{mol}]_{unirrad.})$ is found to be the largest for the alloy with x = 0.4 (insert, Fig. 5), showing the essential increase of the disorder degree under radiation. We believe that this funding is due to the best homogeneous structure of the glass leading to the favoured conditions for the above mentioned reactions (1)-(3) (Figs. 6-8) and, thus, to the radiation-induced structural changes on the short- and medium-range order scales.

5. Conclusions

structural Radiation-induced changes the chalcogenide glasses of the $(As_2S_3)_x(GeS_2)_{1-x}$ system (x = 0.1, 0.2, 0.4, 0.6) have been studied in detail by using the Raman spectroscopy technique. Employing the differential representation of the depolarized (VH) Raman spectra measured for the γ-irradiated and unirradiated samples, it has been found that the radiation-induced structural changes are significant only for the glass composition with x = 0.4, while these changes are practically absent in the case of the glass compositions with x = 0.1, 0.2 and 0.6. The applied differential procedure has also allowed to detect the radiation-induced effects in clusters of corner-shared and edge-shared tetrahedra. It has been concluded that the controversial companion $A_{\rm l}^c$ mode at $370\,{\rm cm}^{-1}$ to the main 340 cm^{-1} A_1 symmetric mode of vibrations in corner-shared tetrahedra seems to be related mainly to the vibrations of edge-shared tetrahedra. The possible nanoscale structural mechanism to account for the observed spectral changes has been discussed. As a result, three y-induced covalent bond switching reactions have been identified: the reaction (1) with the \equiv Ge - S - As = configuration [(Ge - S) \rightarrow (As - S)] accompanied by formation of $(As_4^+ + Ge_3^-)$ VAP defects; the reaction (2) with the CS-GeS₄ configuration $[(Ge - S) \rightarrow (S - S)]$ accompanied by formation of $(S_3^+ + Ge_3^-)$ VAP defects; and the reaction (3) with the ES-GeS₄ configuration $[(Ge - S) \rightarrow (S - S)]$ accompanied

by formation of $(S_3^+ \cdot Ge_3^-)$ VAP-d defects. It has also been ascertained that the composition dependence of the disorder degree examplified by the ratio of $I_{\text{bos}}/I_{\text{mol}}$ supports the specific radiation-induced structural changes detected for the alloy with x = 0.4.

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